## **Amendments to the Specification**

Please replace the paragraph beginning at page 10, line 18, with the following rewritten paragraph:

The illumination-optical system IOS also includes a subfield-selection deflector 108 situated downstream of the blanking aperture 107. The subfield-selection deflector 108 primarily serves to scan (sweep) the illumination beam IB (to the left and right in the X direction) to illuminate, in a successive manner, a series of subfields of the reticle 110 that are located within the optical field of the illumination-optical system IOS. The illumination lens 109 is situated downstream of the subfield-selection deflector 108.